

<b>Notice of References Cited</b>	Application/Control No. 10/812,887	Applicant(s)/Patent Under Reexamination EHATA, KATSUFUMI	
	Examiner Jeff Natalini	Art Unit 2858	Page 1 of 1

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.